Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination
10/790,801	KONO ET AL.
Examiner	Art Unit
Brian S. Kwon	1614

SEARCHED			
Class	Subclass	Date	Examiner
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
STN (Reg, CAPLUS, BIOSIS, EMBASE)	4/16/2006	bk
EAST, NPL		
Continuity Data, Inventor Name search		
10/790790,10129361		